#### FEATURES

DESCRIPTION

- Operating Frequency Range: DC to 3.2GHz
- Operating Drain Voltage: 28V & 50V
- Maximum Output Power (PSAT): 200W
- Bare die shipped in Gel-Pak containers
- Suitable for CW, Pulsed, Linear applications
- 100% KGD DC Production Tested

# The GD200 is a 200W (P3dB) unmatched discrete GaN-on-SiC HEMT which operates from DC to 3.2 GHz on a 50V supply rail. The wide bandwidth of the GD200 makes it suitable for a variety of applications including cellular infrastructure, radar, communications, and test instrumentation, and can support CW, linear and pulse operations.

Bare die are shipped in Gel-Pak containers for safe transport and storage.

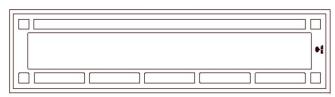
#### ABSOLUTE MAXIMUM RATINGS<sup>(1, 2)</sup>

Parameter	Rating	Symbols and Units
Drain Source Voltage	150	$V_{DS}(V)$
Gate Source Voltage	-8 to +2	V <sub>GS</sub> (V)
Operating Voltage	55	V <sub>dsq</sub> (V)
Junction Temperature	+225	T <sub>JUNC</sub> (°C)
Storage Temperature	-65 to +150	T <sub>STORAGE</sub> (°C)

 Exceeding any of these limits may cause permanent damage to this device or seriously limit the life time (MTTF)
GalliumSemi does not recommend sustained operation above maximum operating conditions.

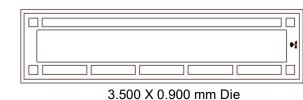


**BLOCK DIAGRAM** 



DRAIN

GATE





# 50V, DC – 3.2GHz, 200W GaN HEMT



# 50V, DC - 3.2GHz, 200W GaN HEMT

#### **ELECTRICAL SPECIFICATION: TA = 25°C**

Parameter	Min.	Тур.	Max.	Symbols and Units	Test conditions
Frequency Range	DC		3200	MHz	
DC Characteristics					
Drain Source Breakdown Voltage	150			V <sub>BDSS</sub> (V)	
Drain Source Leakage Current		4.4		I <sub>DLK</sub> (mA)	Vgs = -8V, Vds = 50V
Gate Threshold Voltage	-3.4		-1.5	V <sub>GS</sub> (V)	Vds = 50V
Operating Conditions					
Gate Bias Voltage		-2.5		V <sub>GSQ</sub> (V)	
Drain Voltage		50		V <sub>DSQ</sub> (V)	
Quiescent Drain Current		200		I <sub>DQ</sub> (mA)	



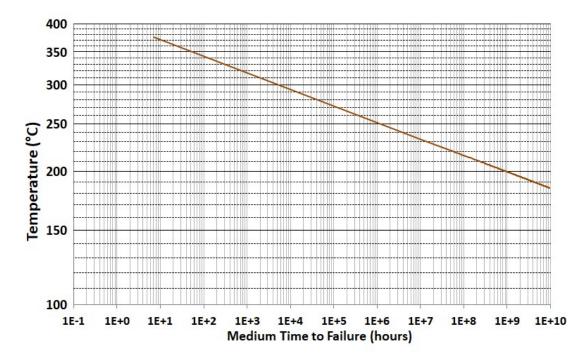
#### 50V, DC - 3.2GHz, 200W GaN HEMT

#### THERMAL AND RELABILITY INFORMATION -CW <sup>(1, 2)</sup>: T<sub>c</sub> = 85°C

Parameter	Test condition	Value	Units	Notes
Channel Temperature, Tch		250	°C	
Rth die	Pdiss 80 W	2.06	°C/W	
MTTF		1.0E6	Hrs	

1.Assumes eutectic attach using 1mil low temp solder, mounted to a 8 mil DFN package.

2:Thermal Resistance using Finite Element Analysis (FEA) simulation, calibrated with Infrared measurement on surface temperature.





# 50V, DC – 3.2GHz, 200W GaN HEMT

#### GaN HEMT BIASING SEQUENCE

#### To turn the transistor ON

- 1. Set V<sub>GS</sub> to -5V
- 2. Turn on  $V_{DS}$  to normal operation voltage (50V)
- 3. Slowly increase V<sub>GS</sub> to set I<sub>DQ</sub> current (200 mÅ)
- 4. Apply RF power

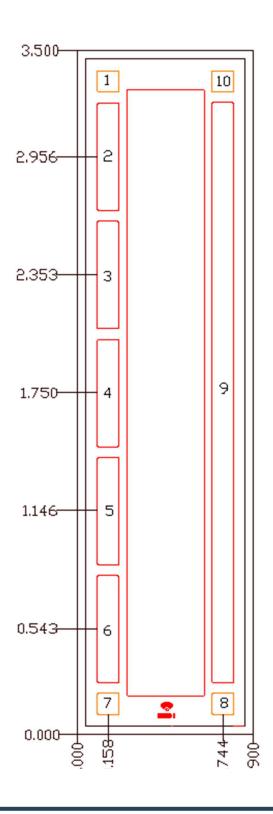
#### To turn the transistor OFF

- 1. Turn the RF power off
- 2. Decrease V<sub>GS</sub> to -1.5V
- 3. Turn off  $V_{\text{D.}}$  Wait a few seconds for drain capacitor to discharge
- 4. Turn off V<sub>GS</sub>



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#### **DIE DIMENSIONS**



#### **BOND PADS**

Pad nb.	Description	Dimensions
1, 7, 8, 10	Not connected	
2, 3, 4, 5, 6	RF Input / Gate Voltage	0.110 x 0.550
9	RF Output / Drain Voltage	0.110 x 2.966
Backside	Source/ Ground	0.900 x 3.500

Notes:

- 1. All dimensions are in millimeter
- 2. Die thickness is 75 um
- 3. Bond pad metallization: gold
- 4. Backside metallization: gold



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#### HANDLING PRECAUTIONS

Parameter	Symbol	Class	Test Methodology
ESD*-Human Body Model	HBM	Class 1A (250 V)	ANSI/ESDA/JEDEC Standard JS-001
ESD*-Charged Device Model	CDM	Class C3 (1500 V)	ANSI/ESDA/JEDEC Standard JS-002

\* Tested in DFN 3x6 package





#### 50V, DC - 3.2GHz, 200W GaN HEMT

#### CONTACT INFORMATION

To request latest information and samples, please contact us at:

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